

Notice of References Cited	Application/Control No. 10/560,828		Applicant(s)/Patent Under Reexamination XIA ET AL.	
	Examiner David Buttner		Art Unit 1796	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,602,599	08-2003	Toyoda et al.	428/355AC
*	B	US-2003/0134108	07-2003	Lakatosh et al.	428/343
*	C	US-5,902,678	05-1999	Konda et al.	428/345
*	D	US-5,914,283	06-1999	Yamada et al.	442/117
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*	F	US-5,637,395	06-1997	Uemura et al.	428/343
*	G	US-5,326,605	07-1994	Ono et al.	428/41.2
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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